

Sheet 1 of 1

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

LIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

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10/611,867

APPLICANT
Tomohiro OKUMURA et al.

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July 3, 2003

GROUP
2812

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
	AJ					
	AK					
	AL					
	AM					
	AN					

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

AO	B. Mizuno et al., "NEW DOPING METHOD FOR SUBHALF MICRON TRENCH SIDEWALLS BY USING AN ELECTRON CYCLOTRON RESONANCE PLASMA", Applied Physics Letters, Vol. 53, No. 21, November 1998, pages 2059-2061, published by American Institute of Physics.
AP	
AQ	

EXAMINER *[Signature]*

DATE CONSIDERED 10/31/05

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of form with next communication to applicant.